

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/721,751	SHIINA ET AL.	
Examiner		Art Unit	Lee Lum	

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,661,031	05-1972	Mizukoshi et al.	74/462
*	B	US-3,810,395	05-1974	Takahashi et al.	74/89.23
*	C	US-3,710,640	01-1973	Stanger et al.	74/425
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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